Search Notes			

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/087,948	NAKANISHI ET AL.	
Examiner	Art Unit	
Ouan-Zhen Wang	2633	

	SEAR	CHED	
Class	Subclass	Date	Examiner
398	164,135	10/15/2005	QZW
385	49,88,89	10/15/2005	QZW
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INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
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SEAR (INCLUDING S	CH NOTES EARCH STRATEGY)
	DATE	EXMR
EAST Search (see attachment)	10/15/2005	qzw
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